

# STARPOWER

SEMICONDUCTOR

**IGBT**

## GD1200SGL330A4S

**3300V/1200A 1 in one-package**

### General Description

STARPOWER IGBT Power Module provides ultra low conduction loss as well as short circuit ruggedness. They are designed for the applications such as high power converters.

### Features

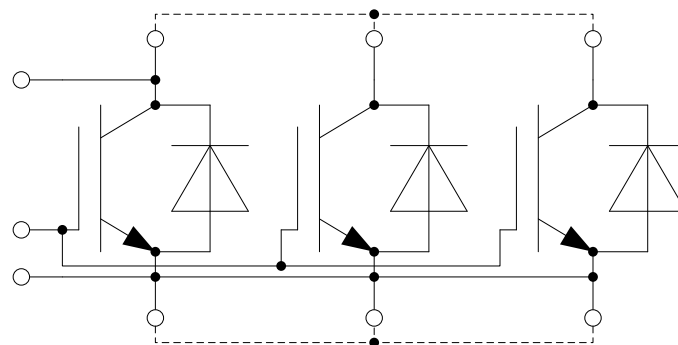
- Low  $V_{CE(sat)}$  SPT IGBT technology
- Low switching losses
- 10 $\mu$ s short circuit capability
- $V_{CE(sat)}$  with positive temperature coefficient
- AlSiC baseplate for high power cycling capability
- AlN substrate for low thermal resistance
- High reliability package



### Typical Applications

- High Power Converter
- Wind Power
- Traction Drive

### Equivalent Circuit Schematic



**Absolute Maximum Ratings**  $T_C=25^{\circ}\text{C}$  unless otherwise noted**IGBT**

| Symbol    | Description   | Value        | Unit |
|-----------|---|--------------|------|
| $V_{CES}$ | Collector-Emitter Voltage   | 3300         | V    |
| $V_{GES}$ | Gate-Emitter Voltage  | $\pm 20$     | V    |
| $I_C$     | Collector Current @ $T_C=25^{\circ}\text{C}$<br>@ $T_C=100^{\circ}\text{C}$ | 2300<br>1200 | A    |
| $I_{CM}$  | Pulsed Collector Current $t_p=1\text{ms}$                                   | 2400         | A    |
| $P_D$     | Maximum Power Dissipation @ $T_j=150^{\circ}\text{C}$                       | 14.71        | kW   |

**Diode**

| Symbol    | Description                                    | Value | Unit |
|-----------|--|-------|------|
| $V_{RRM}$ | Repetitive Peak Reverse Voltage                | 3300  | V    |
| $I_F$     | Diode Continuous Forward Current               | 1200  | A    |
| $I_{FM}$  | Diode Maximum Forward Current $t_p=1\text{ms}$ | 2400  | A    |

**Module**

| Symbol     | Description   | Value       | Unit               |
|------------|---|-------------|--------------------|
| $T_{jmax}$ | Maximum Junction Temperature  | 150         | $^{\circ}\text{C}$ |
| $T_{jop}$  | Operating Junction Temperature  | -40 to +125 | $^{\circ}\text{C}$ |
| $T_{STG}$  | Storage Temperature Range   | -40 to +125 | $^{\circ}\text{C}$ |
| $V_{ISO}$  | Isolation Voltage RMS, $f=50\text{Hz}$ , $t=1\text{min}$  | 6000        | V                  |
| $V_{ISO}$  | Partial Discharge Extinction Voltage<br>IEC1287, RMS, $f=50\text{Hz}$ , $Q_{PD} \leq 10\text{pC}$ | 2600        | V                  |

**IGBT Characteristics**  $T_c=25^\circ\text{C}$  unless otherwise noted

| Symbol        | Parameter                               | Test Conditions  | Min. | Typ. | Max. | Unit          |
|---------------|---|--|------|------|------|---------------|
| $V_{CE(sat)}$ | Collector to Emitter Saturation Voltage | $I_C=1200\text{A}, V_{GE}=15\text{V}, T_j=25^\circ\text{C}$  |      | 3.10 | 3.40 | V             |
|               |   | $I_C=1200\text{A}, V_{GE}=15\text{V}, T_j=125^\circ\text{C}$   |      | 3.80 |      |               |
| $V_{GE(th)}$  | Gate-Emitter Threshold Voltage          | $I_C=240\text{mA}, V_{CE}=V_{GE}, T_j=25^\circ\text{C}$  | 5.5  |      | 7.5  | V             |
| $I_{CES}$     | Collector Cut-Off Current               | $V_{CE}=V_{CES}, V_{GE}=0\text{V}, T_j=25^\circ\text{C}$   |      |      | 12.0 | mA            |
| $I_{GES}$     | Gate-Emitter Leakage Current            | $V_{GE}=V_{GES}, V_{CE}=0\text{V}, T_j=25^\circ\text{C}$   |      |      | 500  | nA            |
| $C_{ies}$     | Input Capacitance                       | $V_{CE}=25\text{V}, f=1\text{MHz}, V_{GE}=0\text{V}$   |      | 187  |      | nF            |
| $C_{res}$     | Reverse Transfer Capacitance            |  |      |      | 2.22 |               |
| $Q_G$         | Gate Charge                             | $V_{CE}=1800\text{V}, V_{GE}=-15\dots+15\text{V}$  |      | 12.1 |      | $\mu\text{C}$ |
| $t_{d(on)}$   | Turn-On Delay Time                      | $V_{CC}=1800\text{V}, I_C=1200\text{A}, R_G=1.5\Omega, V_{GE}=\pm 15\text{V}, T_j=25^\circ\text{C}$                |      | 400  |      | ns            |
| $t_r$         | Rise Time                               |  |      | 180  |      | ns            |
| $t_{d(off)}$  | Turn-Off Delay Time                     |  |      | 950  |      | ns            |
| $t_f$         | Fall Time                               |  |      | 350  |      | ns            |
| $E_{on}$      | Turn-On Switching Loss                  |  |      | 1340 |      | mJ            |
| $E_{off}$     | Turn-Off Switching Loss                 |  |      | 1420 |      | mJ            |
| $t_{d(on)}$   | Turn-On Delay Time                      | $V_{CC}=1800\text{V}, I_C=1200\text{A}, R_G=1.5\Omega, V_{GE}=\pm 15\text{V}, T_j=125^\circ\text{C}$               |      | 405  |      | ns            |
| $t_r$         | Rise Time                               |  |      | 200  |      | ns            |
| $t_{d(off)}$  | Turn-Off Delay Time                     |  |      | 1200 |      | ns            |
| $t_f$         | Fall Time                               |  |      | 450  |      | ns            |
| $E_{on}$      | Turn-On Switching Loss                  |  |      | 1890 |      | mJ            |
| $E_{off}$     | Turn-Off Switching Loss                 |  |      | 1950 |      | mJ            |
| $I_{SC}$      | SC Data                                 | $t_p \leq 10\mu\text{s}, V_{GE}=15\text{V}, T_j=125^\circ\text{C}, V_{CC}=2500\text{V}, V_{CEM} \leq 3300\text{V}$ |      | 5000 |      | A             |

**Diode Characteristics**  $T_C=25^{\circ}\text{C}$  unless otherwise noted

| Symbol    | Parameter                     | Test Conditions  | Min. | Typ. | Max. | Unit          |
|-----------|-------------------------------|--|------|------|------|---------------|
| $V_F$     | Diode Forward Voltage         | $I_F=1200\text{A}, V_{GE}=0\text{V}, T_j=25^{\circ}\text{C}$   |      | 2.30 | 2.60 | V             |
|           |                               | $I_F=1200\text{A}, V_{GE}=0\text{V}, T_j=125^{\circ}\text{C}$  |      | 2.35 |      |               |
| $Q_r$     | Recovered Charge              | $V_R=1800\text{V}, I_F=1200\text{A},$<br>$-di/dt=5400\text{A}/\mu\text{s}, V_{GE}=-15\text{V},$<br>$T_j=25^{\circ}\text{C}$  |      | 715  |      | $\mu\text{C}$ |
| $I_{RM}$  | Peak Reverse Recovery Current |  |      | 1100 |      | A             |
| $E_{rec}$ | Reverse Recovery Energy       |  |      | 840  |      | mJ            |
| $Q_r$     | Recovered Charge              |  |      | 1300 |      | $\mu\text{C}$ |
| $I_{RM}$  | Peak Reverse Recovery Current | $V_R=1800\text{V}, I_F=1200\text{A},$<br>$-di/dt=5400\text{A}/\mu\text{s}, V_{GE}=-15\text{V},$<br>$T_j=125^{\circ}\text{C}$ |      | 1350 |      | A             |
| $E_{rec}$ | Reverse Recovery Energy       |  |      | 1530 |      | mJ            |

**Module Characteristics**  $T_C=25^{\circ}\text{C}$  unless otherwise noted

| Symbol          | Parameter                                | Min. | Typ. | Max. | Unit       |
|-----------------|--|------|------|------|------------|
| $L_{CE}$        | Stray Inductance                         |      | 6    |      | nH         |
| $R_{CC'+EE'}$   | Module Lead Resistance, Terminal to Chip |      | 0.12 |      | m $\Omega$ |
| $R_{\theta JC}$ | Junction-to-Case (per IGBT)              |      |      | 8.50 | K/kW       |
|                 | Junction-to-Case (per Diode)             |      |      | 17.0 |            |
| $R_{\theta CS}$ | Case-to-Sink (per IGBT)                  |      | 9.00 |      | K/kW       |
|                 | Case-to-Sink (per Diode)                 |      | 18.0 |      |            |
| $R_{\theta CS}$ | Case-to-Sink                             |      | 6.0  |      | K/kW       |
| M               | Terminal Connection Torque, Screw M4     | 1.8  |      | 2.1  | N.m        |
|                 | Terminal Connection Torque, Screw M8     | 8.0  |      | 10   |            |
|                 | Mounting Torque, Screw M6                | 4.25 |      | 5.75 |            |
| G               | Weight of Module                         |      | 1200 |      | g          |

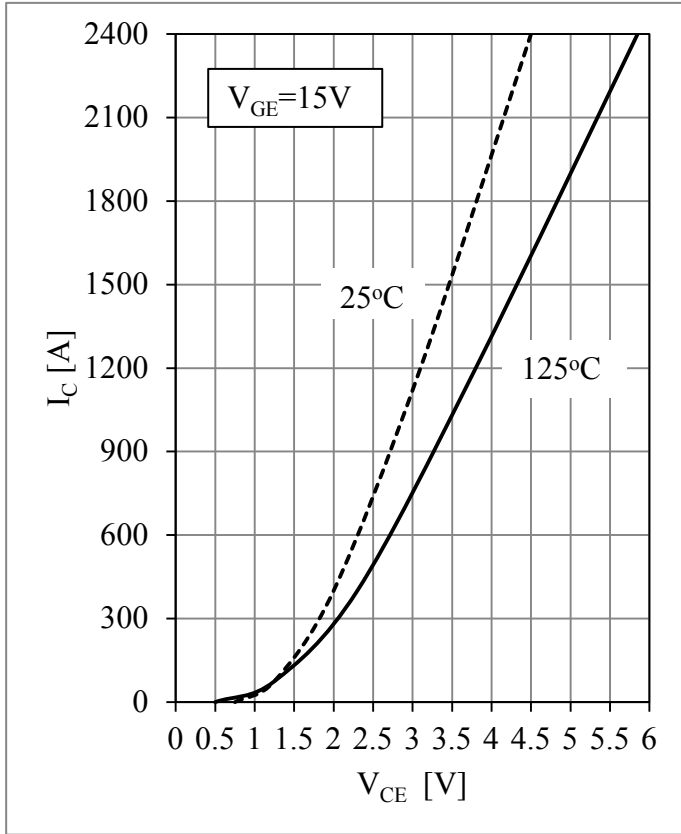


Fig 1. IGBT Output Characteristics

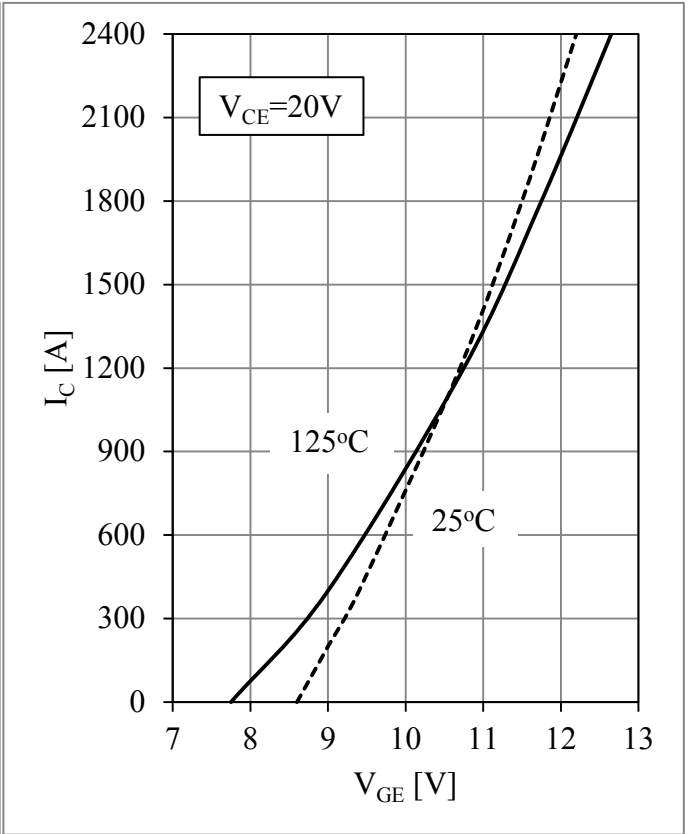


Fig 2. IGBT Transfer Characteristics

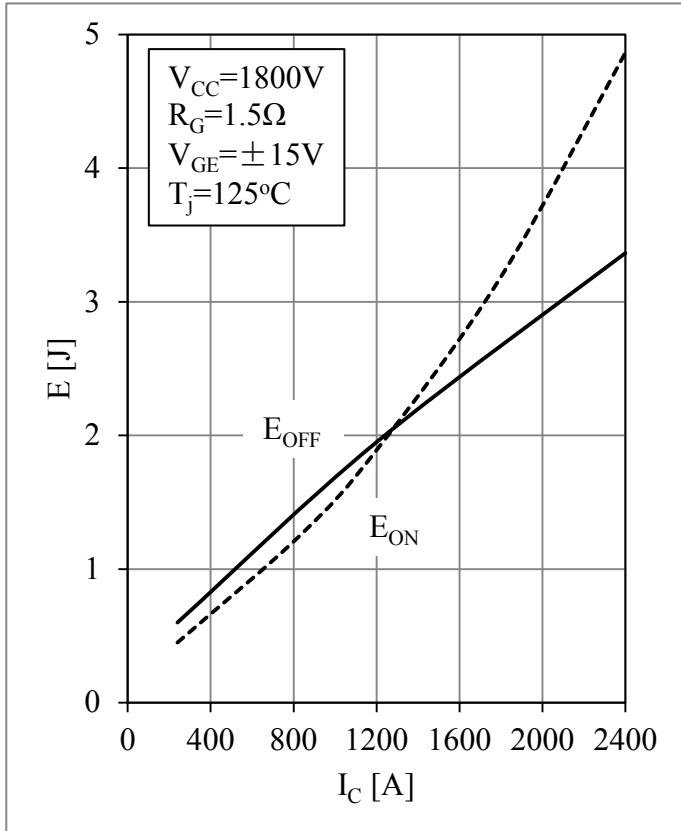


Fig 3. IGBT Switching Loss vs.  $I_c$

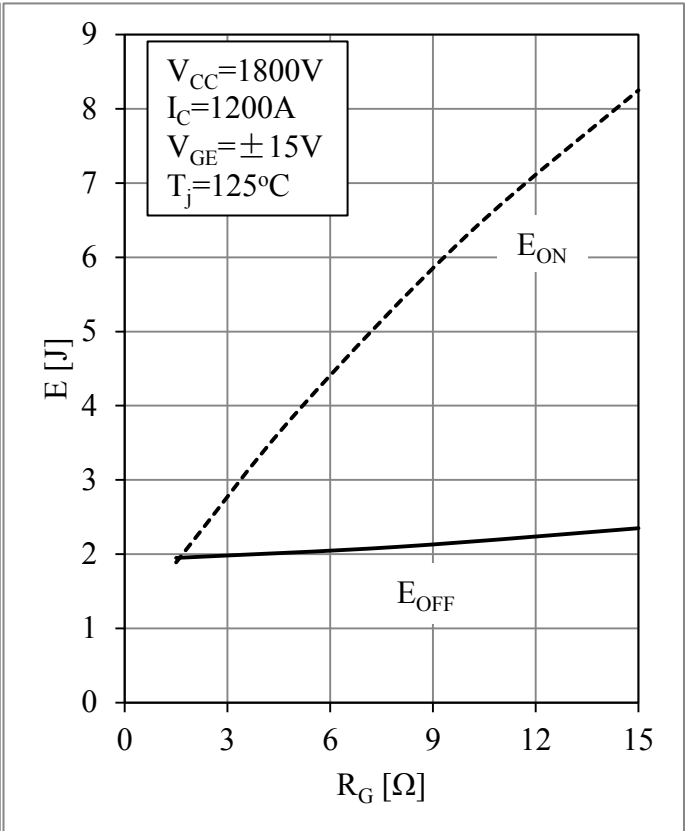


Fig 4. IGBT Switching Loss vs.  $R_g$

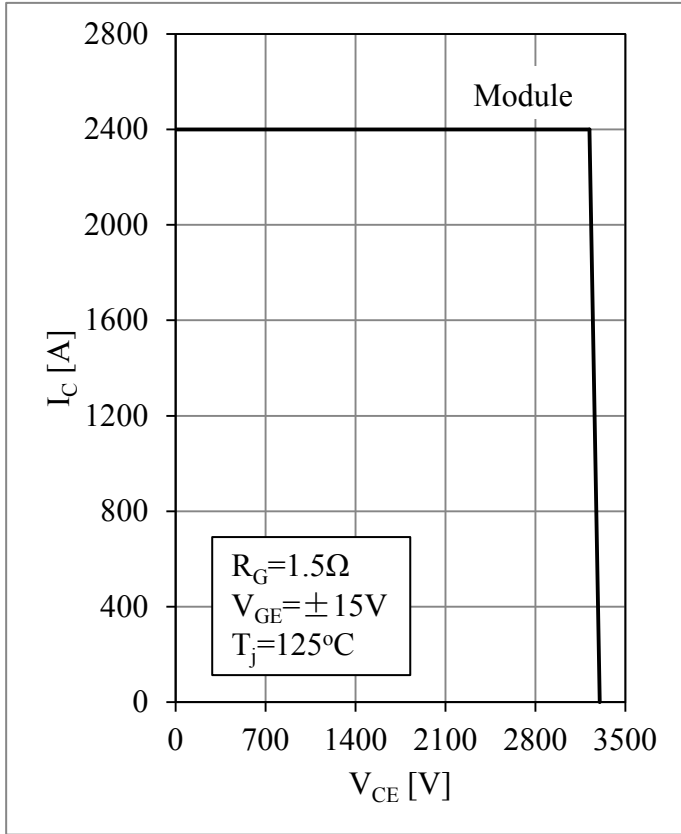


Fig 5. RBSOA

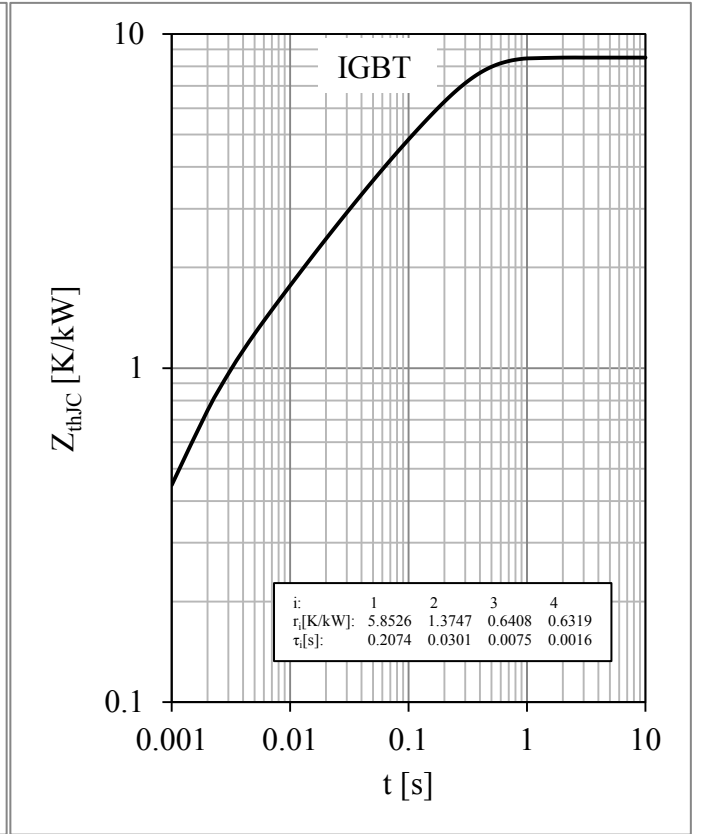


Fig 6. IGBT Transient Thermal Impedance

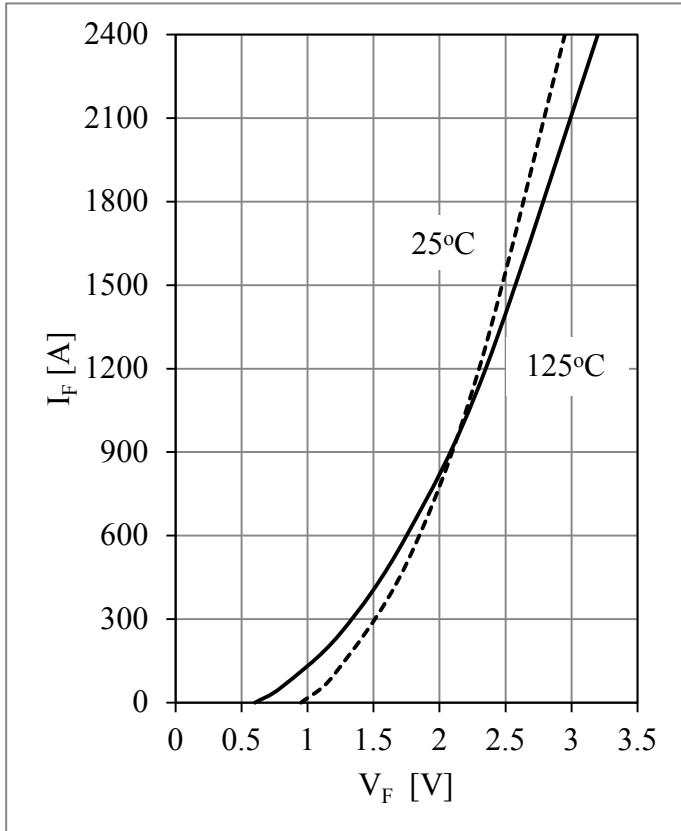


Fig 7. Diode Forward Characteristics

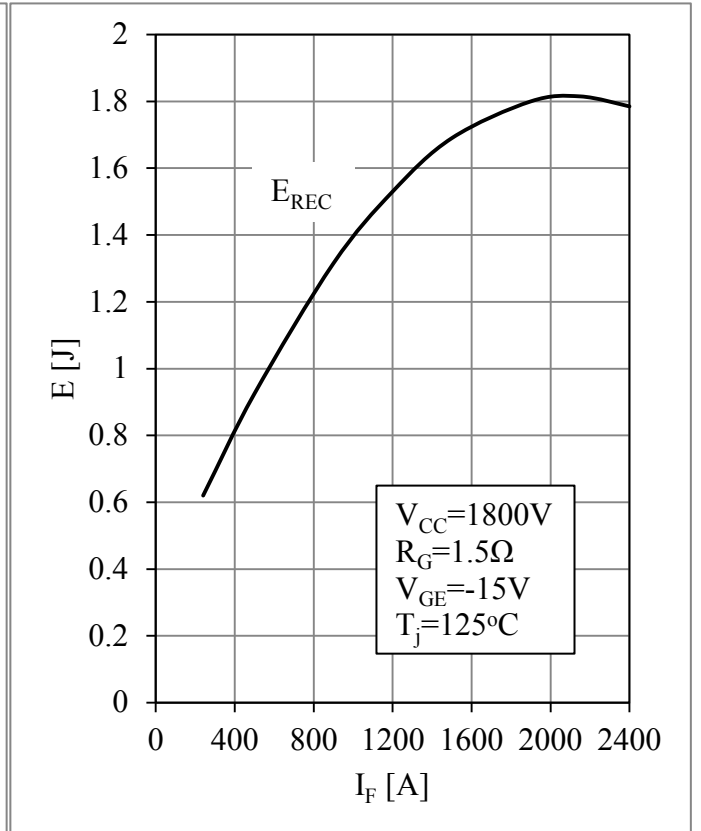


Fig 8. Diode Switching Loss vs.  $I_F$

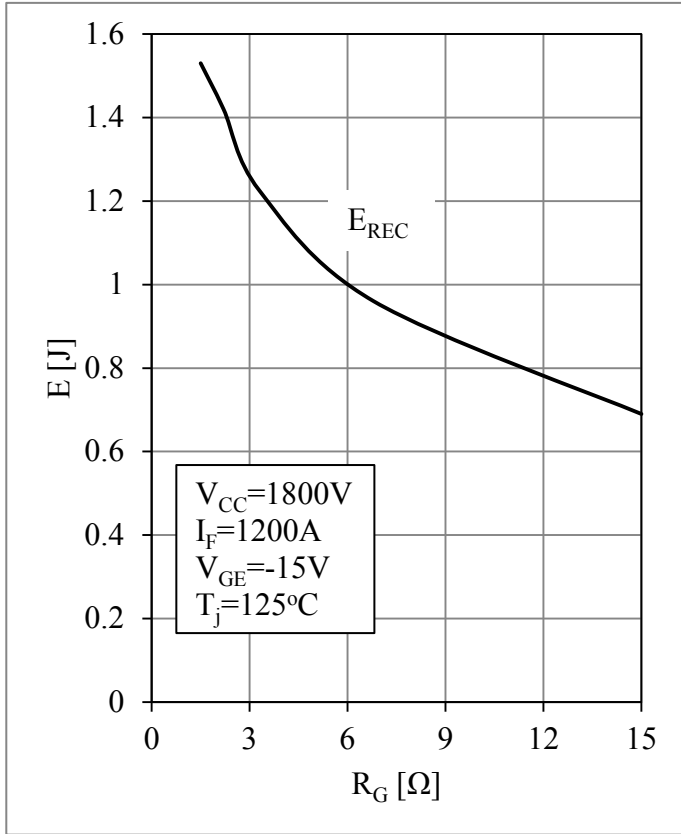


Fig 9. Diode Switching Loss vs.  $R_G$

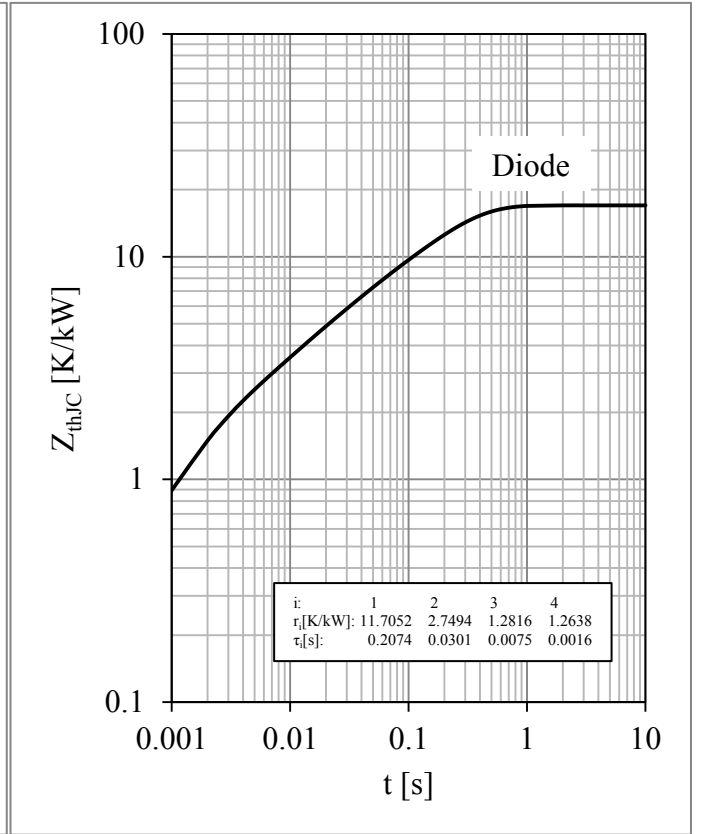


Fig 10. Diode Transient Thermal Impedance





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